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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Youqi Wang et al. Art Unit : 2881
Serial No. : 10/024,649 Examiner : Unknown
Filed : December 17, 2001
Title : METHODS AND APPARATUS FOR PREPARING HIGH-DIMENSIONAL
COMBINATORIAL EXPERIMENTS

Commissioner for Patents
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SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Copies of the references listed on the attached form PTO-1449 are enclosed.

Submitted herewith is an English translation of the following foreign language reference:

Desig. ID	Source
AE	H.-D. Klein, "Statistische Versuchsplanung", 1995, Nachr. Chem. Tech. Lab. Vol. 43, pp. 1078, 1080-1082

This statement is being filed before the receipt of a first Office action on the merits.

Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: 5/28/03

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Substitute Form PTO-1449 (Modified) JC156 JUN 02 2003 (37 CFR §1.98(b)) PATENT & TRADEMARK OFFICE	U.S. Department of Commerce Patent and Trademark Office Information Disclosure Statement by Applicant (Use several sheets if necessary)	Attorney's Docket No. 10555-025001	Application No. 10/024,649
		Applicant Youqi Wang et al.	
		Filing Date December 17, 2001	Group Art Unit 2881

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AC							
	AD							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AE	H.-D. Klein, "Statistische Versuchsplanung", 1995, Nachr. Chem. Tech. Lab. Vol. 43, pp. 1078, 1080-1082 (with English translation).
	AF	
	AG	
	AH	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	